

**Search Notes**

Application/Control No.

10/807,432

Examiner

Nam Huynh

Applicant(s)/Patent under  
Reexamination

YOSHIDA ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
A further evaluation of previously cited references was conducted.	10/25/2007	NTH